Search Notes

Application/Control No.	Applicant(s)/Patent under Reexamination
10/505,479	TAKAHASHI, YORIO
Examiner	Art Unit
Christopher R. Lamb	2627

SEARCHED					
Class	Subclass	Date	Examiner		
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INTERFERENCE SEARCHED					
Class	Subclass	Date	Examiner		
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SEARCH (INCLUDING SEAR	NOTES CH STRATEC	SY)
	DATE	EXMR
Updated EAST Search	7/10/2006	6 CRL